Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/500,114	HAYAKAWA ET AL.	
Examiner	Art Unit	
Vivian Chen	1773	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
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SEARCH (INCLUDING SEAF)
	DATE	EXMR
inventor search	6/5/2006	VC
EAST text search history	6/11/2006	vc